

MSKSEMI 美森科

SEMICONDUCTOR



ESD



TVS



TSS



MOV



GDT



PLED

TLV70XXXDBVR(MS)

Product specification

TLV70XXXDBVR(MS) LOW DROPOUT LINEAR REGULATOR

GENERAL DESCRIPTION

TLV70XXXDBVR(MS) series are a set of Low Dropout Linear Regulator ICs implemented in CMOS technology. They can withstand voltage 30V. And they are available with low voltage drop and low quiescent current, widely used in audio, video and communication appliances.

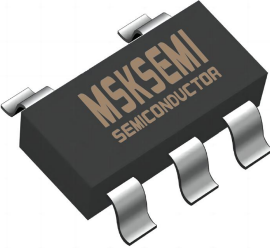
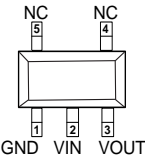
FEATURES

- Low Power Consumption
- Low Voltage Drop
- Low Temperature Coefficient
- Withstanding Voltage 30V
- Quiescent Current 1.5 μ A
- Output Voltage Accuracy: tolerance \pm 2%
- High output current: 100mA

TYPICAL APPLICATIONS

- Battery-powered Equipments
- Communication Equipments
- Audio/Video Equipments

Reference News

PACKAGE OUTLINE	PIN CONFIGURATION
	
SOT-23-5	

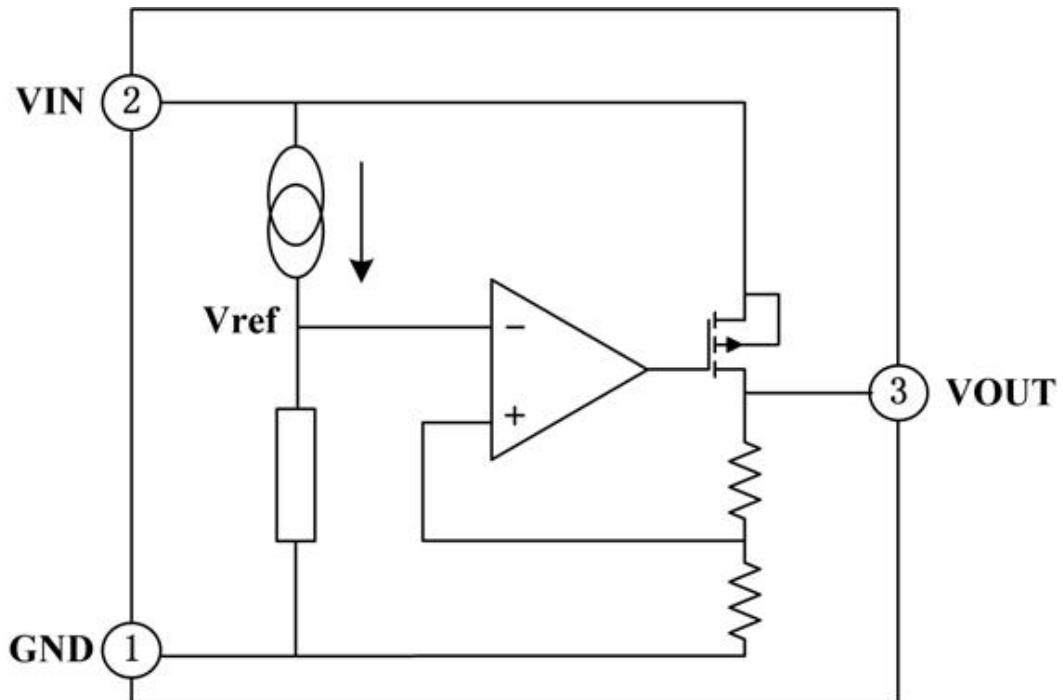
PIN DESCRIPTION

No.	Name	Functions Description
1	GND	ground
2	V _{IN}	input
3	V _{OUT}	output

OUTPUT

Series	Marking	Output	Package
TLV70425	425	2.5V	SOT-23-5
TLV70428	428	2.8V	
TLV70430	QUQ	3.0V	
TLV70433	PA0	3.3V	
TLV70436	436	3.6V	
TLV70440	440	4.0V	
TLV70444	444	4.4V	
TLV70450	PAX	5.0V	

FUNCTIONALBLOCKDIAGRAM



ABSOLUTE MAXIMUM RATINGS

Description	Symbol	Value range	Unit
Limit Power Voltage	V_{IN}	-0.3 ~ +33	V
Storage Temperature Range	T_{STG}	-50 ~ +125	°C
Operating Free-air Temperature Range	T_A	-40 ~ +85	°C

Note : Stresses greater than those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “Recommended Operating Conditions” is not implied. Exposure to “Absolute Maximum Ratings” for extended periods may affect device reliability.

HEAT DISSIPATION

Description	Symbol	Value range Unit
Thermal resistance	θ_{JA}	500 °C/W
Power dissipation	P_W	200 mW

DC CHARACTERISTICS (unless otherwise noted $T_A = \pm 25^\circ\text{C}$)

TLV70425DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	2.45	2.50	2.55	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	30	100	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{\Delta V_{IN}}{\Delta V_{IN}}$ *	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$	—	100	—	ppm/ $^\circ\text{C}$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70428DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	2.744	2.80	2.856	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	30	100	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{\Delta V_{IN}}{\Delta V_{IN}}$ *	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$	—	100	—	ppm/ $^\circ\text{C}$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70430DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	2.94	3.00	3.06	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	30	100	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{V_{OUT}}{\Delta V_{IN}}$	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70433DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	3.234	3.30	3.366	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	25	55	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{V_{OUT}}{\Delta V_{IN}}$	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70436DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	3.528	3.60	3.672	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	25	55	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{1}{\Delta V_{IN}}$	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70440DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	3.92	4.0	4.08	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	25	55	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} \cdot \frac{1}{\Delta V_{IN}}$	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} \cdot V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70444DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	4.312	4.4	4.488	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	70	100	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 50mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	25	55	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} / \frac{\Delta V_{IN}}{V_{IN}}$ *	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} * V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

TLV70450DBVR(MS)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Output Voltage	V_{OUT}	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$	4.9	5.0	5.1	V
Output Current	I_{OUT}	$V_{IN}=V_{OUT}+2.0V$	100	150	—	mA
Load Regulation	ΔV_{OUT}	$V_{IN}=V_{OUT}+2.0V$ $1mA \leq I_{OUT} \leq 70mA$	—	25	60	mV
Voltage Drop	V_{DIF}	$I_{OUT}=1mA$, $\Delta V_{OUT}=2\%$	—	25	55	mV
Quiescent Current	I_{SS}	No Load	—	1.5	3.0	μA
Line Regulation	$\frac{\Delta V_{OUT}}{V_{OUT}} / \frac{\Delta V_{IN}}{V_{IN}}$ *	$V_{OUT}+1.0V \leq V_{IN} \leq 30V$, $I_{OUT}=1mA$	—	—	0.2	%/V
Input Voltage	V_{IN}	—	—	—	30	V
Temperature Coefficient	$\frac{\Delta V_{OUT}}{\Delta T_A} * V_{OUT}$	$V_{IN}=V_{OUT}+2.0V$, $I_{OUT}=10mA$, $-40^\circ C \leq T_A \leq 85^\circ C$	—	100	—	ppm/ $^\circ C$

Note : When $V_{IN}=V_{OUT}+2.0V$, as the output voltage declined 2%, the $V_{DIF}=V_{IN}-V_{OUT}$.

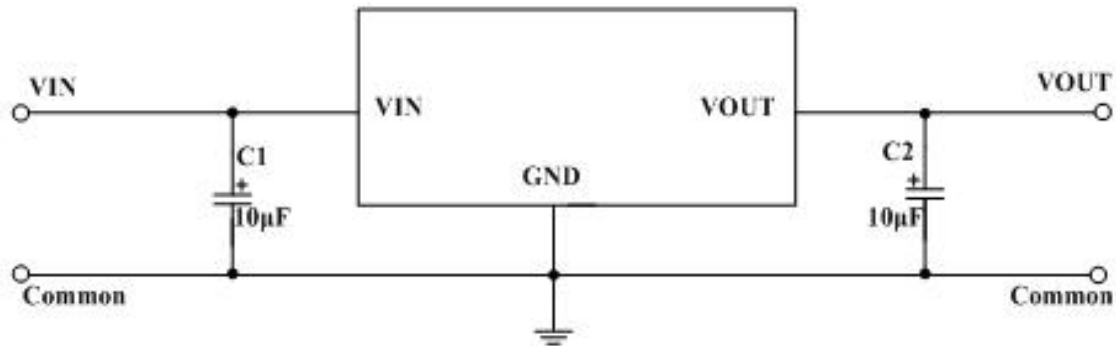
FUNCTIONAL DESCRIPTION

TLV70XXXDBVR(MS) series are linear voltage regulator ICs withstanding 30V voltage. The series IC consists of a voltage reference, an error amplifier, a current limiter and a phase compensation circuit plus a driver transistor. The output stabilization capacitor is also compatible with low ESR ceramic capacitors.

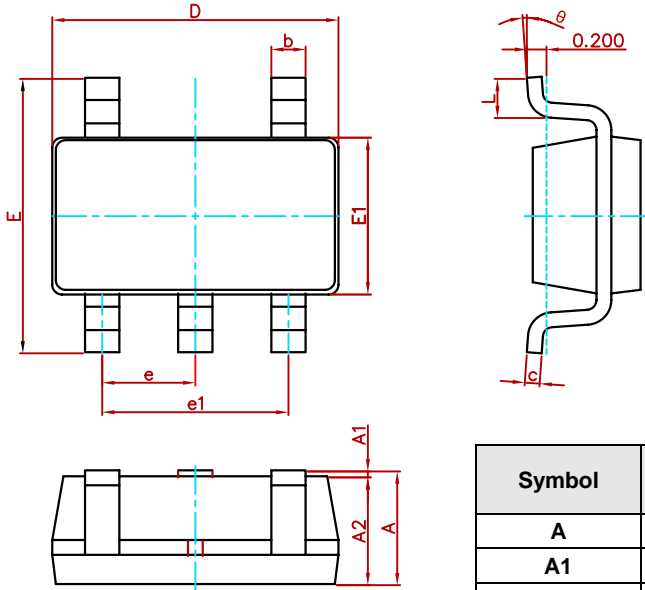
The over current protection circuit and the over voltage protection circuit are built-in. The protection circuit will operate when the output current or input voltage reaches limit level.

TYPICAL APPLICATION CIRCUIT

Basic Circuit

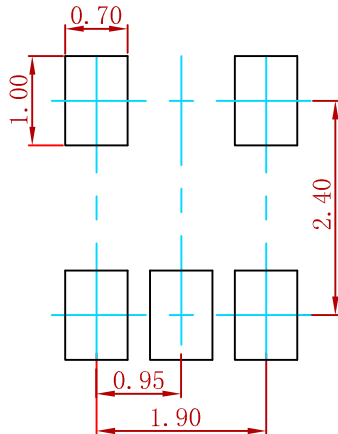


Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	2.650	2.950	0.104	0.116
E1	1.500	1.700	0.059	0.067
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:
 1. Controlling dimension: in millimeters.
 2. General tolerance: $\pm 0.05\text{mm}$.
 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
TLV70XXXDBVR(MS)	SOT-23-5	3000

Attention

- Any and all MSKSEMI Semiconductor products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your MSKSEMI Semiconductor representative nearest you before using any MSKSEMI Semiconductor products described or contained herein in such applications.
- MSKSEMI Semiconductor assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all MSKSEMI Semiconductor products described or contained herein.
- Specifications of any and all MSKSEMI Semiconductor products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- MSKSEMI Semiconductor strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all MSKSEMI Semiconductor products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of MSKSEMI Semiconductor.
- Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. MSKSEMI Semiconductor believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the MSKSEMI Semiconductor product that you intend to use.

单击下面可查看定价，库存，交付和生命周期等信息

[>>MSKSEMI\(美森科\)](#)